

<b>Notice of References Cited</b>	Application/Control No. 10/560,701	Applicant(s)/Patent Under Reexamination BINSTEAD, RONALD P.	
	Examiner VINH LAM	Art Unit 2629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,657,053 A	08-1997	Files et al.	345/177
*	B	US-6,297,811 B1	10-2001	Kent et al.	345/173
*	C	US-2002/0000977 A1	01-2002	Vranish, John M.	345/173
*	D	US-2002/0101409 A1	08-2002	Yokoyama et al.	345/173
*	E	US-2003/0112226 A1	06-2003	Le-Pailleur, Laurent	345/173
*	F	US-6,628,269 B2	09-2003	Shimizu, Toshiyuki	345/173
*	G	US-2003/0231170 A1	12-2003	Yoshikawa et al.	345/173
*	H	US-2004/0017364 A1	01-2004	Tanaka et al.	345/173
*	I	US-2004/0119701 A1	06-2004	Mulligan et al.	345/173
*	J	US-6,788,294 B2	09-2004	Takala et al.	345/173
*	K	US-6,954,868 B2	10-2005	Lin et al.	713/324
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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